

Supporting Information for

**X-ray photochromism of chalcogenide frameworks linked
with metal-amine chelates**

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I. Experimental Section

Chemicals and Materials. Tin powder (Sn, 99.99%), zinc acetate dihydrate ($\text{Zn}(\text{CH}_3\text{COO})_2 \cdot 2\text{H}_2\text{O}$, 99.9%), sulfur powder (S, 99%), 2-(2-Aminoethylamino)ethanol (AEAE, 99%), 1,2-diaminocyclohexane (DAC, 99%), N,N'-dimethyl-1,2-cyclohexanediamine (DAC-Me), and 1,8-diazabicyclo[5.4.0]undec-7-ene (DBU, 98%) were commercially available and used as received.

[Zn(DAC)]₂SnS₄·(H₂O) (1)

The mixture of $\text{Zn}(\text{CH}_3\text{COO})_2 \cdot 2\text{H}_2\text{O}$ (55 mg, 0.25 mmol), Sn (30 mg, 0.25 mmol), S (96 mg, 3 mmol), DAC (2 mL), AEAE (1 mL), and DBU (3 mL) were stirred in a 23 mL Teflon-lined stainless steel autoclave for 20 mins. After the vessel was sealed and heated at 180 °C for 8 days, the autoclave was taken out and gradually cooled to room temperature. The pale yellowish octahedral crystals were obtained by filtration, washed with ethanol, and dried in vacuum (yield 30.8% based on Zn). The phase purity of the sample was identified by powder X-ray diffraction measurements.

[Zn(DAC-Me)]₂SnS₄·(H₂O) (1-Me)

Following the aforementioned procedures, **1-Me** can be obtained by using DAC-Me instead of DAC for solvothermal reaction. A large quantity of clear yellowish crystals was obtained by filtration, washed with ethanol, and dried in vacuum (yield 35.8% based on Zn). The phase purity of the sample was identified by powder X-ray diffraction measurements.

II. Physical measurements

Powder X-ray Diffraction Characterization. The Powder X-ray Diffraction (PXRD) data was collected on a desktop diffractometer (D2 PHASER, Bruker, Germany) using Cu-K α ($\lambda=1.54056$ Å) radiation operated at 30 kV and 10 mA. The samples were ground into fine powders for several minutes before the test.

Single-Crystal X-ray Crystallography. Intensity data of **1** were recorded on Bruker Photon II CPAD diffractometer with graphite monochromated Mo K α ($\lambda = 0.71073$ Å) radiation at 120 K, whereas that of **1-Me** were collected on an Agilent SuperNova Dual system (Cu K α) at 100 K. Absorption corrections were applied by using the program CrysAlis (multi-scan). The structures were solved by direct method, and nonhydrogen atoms were refined anisotropically by least-squares on F^2 using the SHELXTL program. The data collection and refinement parameters for **1** and **1-Me** are summarized in Table S1.

Elemental Analysis. Energy dispersive spectroscopy (EDS) analysis was performed on scanning electron microscope (SEM) equipped with EDS detector. An accelerating voltage of 25 kV and 40 s accumulation time were applied. Elemental analysis of C, H, and N was performed on VARIDEL III elemental analyzer.

	Elements (wt.)	N (%)	C (%)	H (%)
1	Calculated	8.97	23.08	4.81
	Experimental	8.91	24.02	4.57
1-Me	Calculated	8.28	28.42	5.07
	Experimental	8.29	28.05	5.18

Thermogravimetric analysis. Thermogravimetric analysis (TGA) was carried out on a Shimadzu TGA-50 thermal analyzer by heating the sample from room temperature to 800 °C with heating rate of 10 °C /min under N₂ flow.

Fourier transform infrared (FT-IR) measurement. FT-IR spectra was performed on a Thermo Nicolet Avatar 6700 FT-IR spectrometer with diamond/zinc selenide optics allowing the instrument to observe from 600-4000 cm^{-1} .

UV-vis diffusion reflectance spectra. Solid-state UV-vis diffusion reflectance spectra (UV-vis DRS) of **1** and **1-Me** were conducted on a SHIMADZU UV-3600 UV-vis-NIR spectrophotometer coupled with an integrating sphere by using BaSO_4 powder as the reflectance reference. In order to determine the band edge of the direct-gap semiconductor, the relation between the absorption coefficients (α) and the incident photon energy ($h\nu$) is exhibited as $\alpha h\nu = A(h\nu - E_g)^{0.5}$, where A is a constant that relates to the effective masses associated with the valence and conduction bands, and E_g is the optical transition gap of the solid material. By extrapolating the linear region to the abscissa, the optical gap can be estimated.

X-ray photoelectron spectroscopy. X-ray photoelectron spectroscopy (XPS) was collected with a Leeman prodigy spectrometer equipped with a monochromatic Al $K\alpha$ X-ray source and a concentric hemispherical analyzer. All binding energies were calibrated using the C (1s) carbon peak (284.6 eV), which was applied as an internal standard.

Preparation of 1/ITO Film and 1-Me/ITO Film. To prepare the working electrode, 2 mg crystals of **1** or **1-Me** were first ground into fine powders, and then added into 60 μL of 0.5% Nafion (D-521 dispersion, 5% in water and 1-propanol). After ultrasonic treatment for 30 minutes, the obtained suspensions were dropped onto the surface of ITO substrate, and then dried at room temperature.

Transient photocurrent and electrochemical impedance spectroscopy measurement. The transient photocurrent and electrochemical impedance spectroscopy (EIS) experiments were carried out on a CHI760E electrochemistry workstation in a standard three-electrode configuration. The sample coated ITO glass electrode (effective area about 1 cm^2), the saturated calomel electrode (SCE), and the Pt plate electrode were used as the working electrode, reference electrode, and counter

electrode, respectively. The light source was a 150 W high pressure xenon lamp with a horizontal of 25 cm away from the surface of the ITO working electrode. Sodium sulphate aqueous solution (0.5 M, 100 mL) was used as the supporting electrolyte.

Electron spin resonance. Electron spin resonance (ESR) spectra was obtained on the ER200-SRC Bruker X-band spectrometer, which operates at 9.06 GHz under room temperature. Two crystals of equal weight were ground to powders and packed into capillary tubes with a diameter of 0.05 mm and sealed at both ends.

X-ray irradiation. X-ray irradiation was produced by medical radiation equipment with tungsten anode X-ray sources (Monoblock® X-ray generators) with a tube voltage of 80 KVp and a tube current that can be adjusted from 1 μ A to 0.6 mA, corresponding to calibrated dose rates from 0.705 μ Gys⁻¹ to 423 μ Gys⁻¹. A cumulative irradiation of 150 Gy per material (1.225 Gymin⁻¹) was applied, with the same irradiation parameters and time.

For the time-dependent coloration experiment, X-ray irradiation were collected on an X-RAD SmART system equipped with W K α radiation source with a tube voltage of 225 KVp and a tube current that can be adjusted from 1 mA to 13 mA, corresponding to calibrated dose rates from 1.941 Gymin⁻¹ to 26.50 Gymin⁻¹. In all these experiments, the dose rate was fixed at 26.50 Gymin⁻¹.

III. Supporting figures

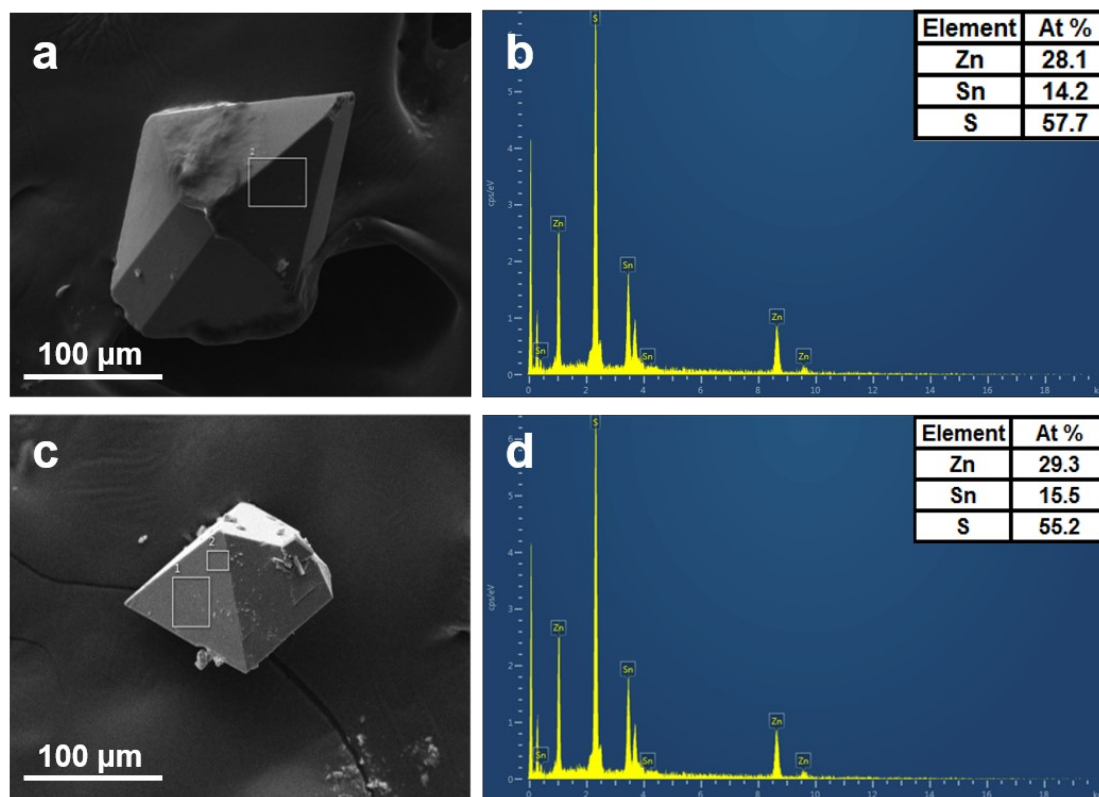


Figure S1. a) SEM image and b) EDS pattern of **1** (EDS analysis of the single crystal of **1** revealed a Zn/Sn atomic ratio of 1.98, which is close to the calculated value of 2.00). c) SEM image and d) EDS pattern of **1-Me** (EDS analysis of **1-Me** revealed a Zn/Sn atomic ratio of 1.89, which is close to the calculated value of 2.00).

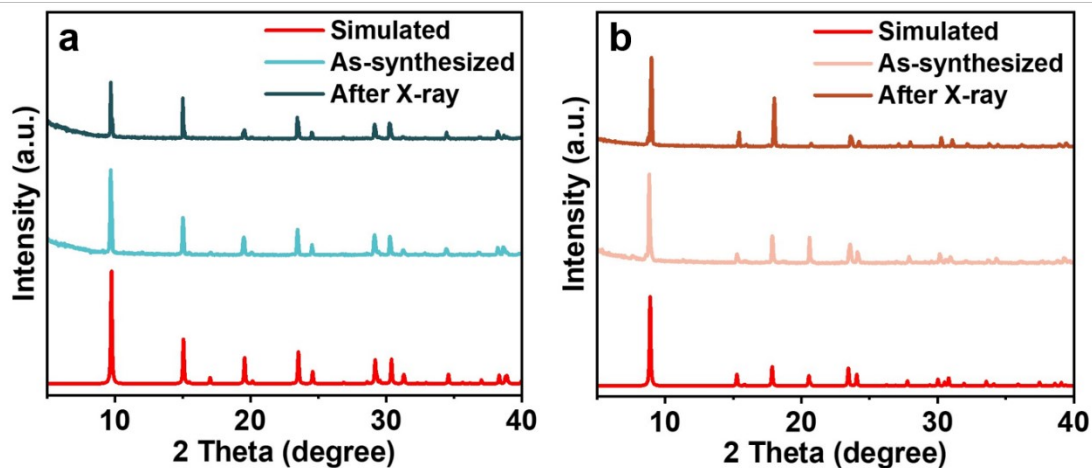


Figure S2. The simulated and experimental (as-synthesized and after X-ray irradiation) PXRD patterns of a) **1** and b) **1-Me**.

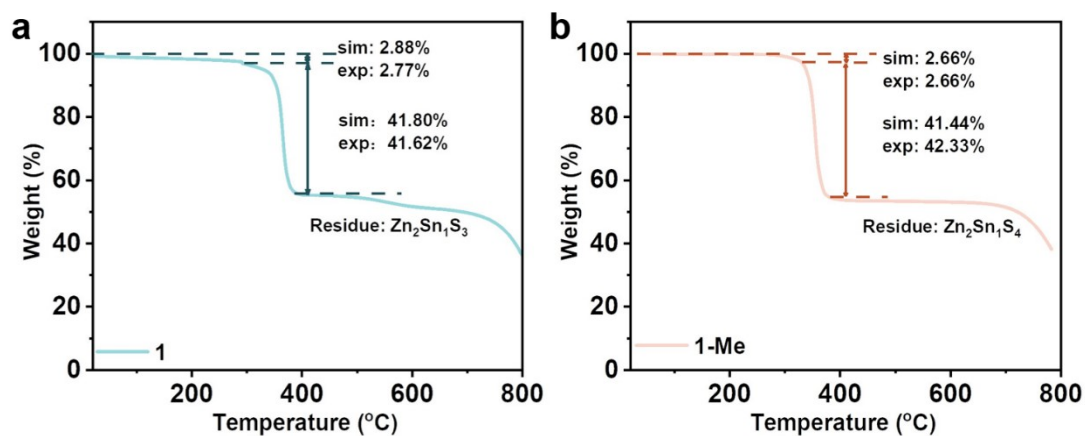


Figure S3. TGA curves of a) **1** and b) **1-Me**.

The two chalcogenide frameworks are stable below 300 °C. The first weight loss below 300 °C is attributed to the desorption of one H₂O molecule. The weight loss from 300-400 °C corresponds to the collapse of the framework and the loss of organic ligands.

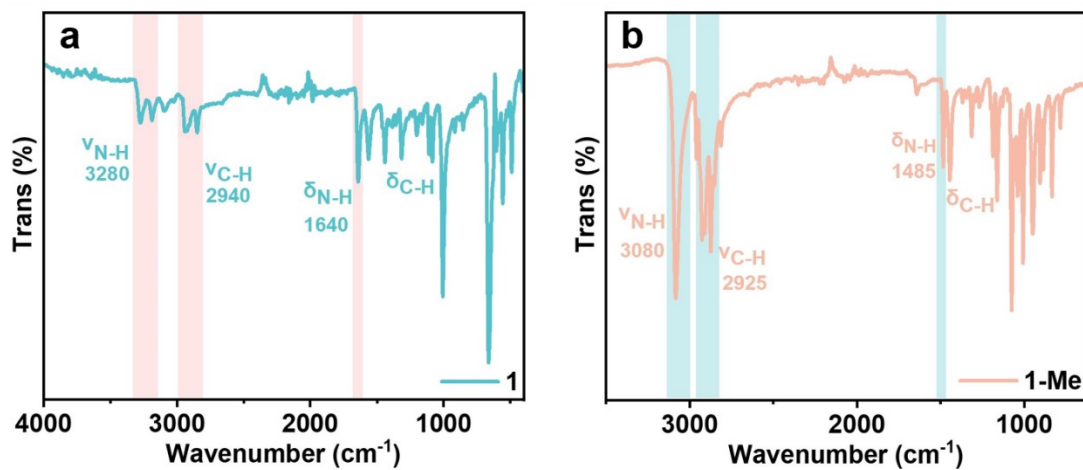


Figure S4. FT-IR spectra of a) **1** and b) **1-Me**.

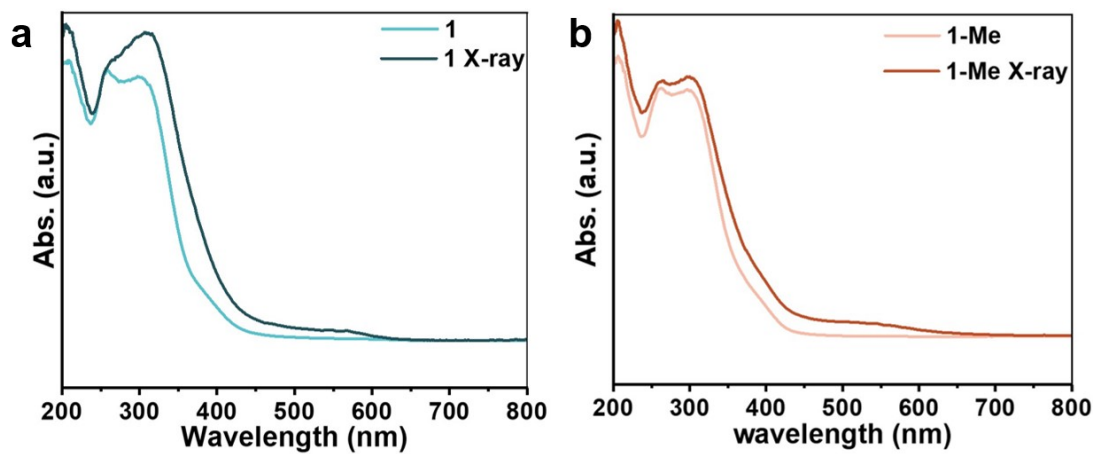


Figure S5. Solid-state diffuse reflectance spectra of a) **1** and b) **1-Me** before and after X-ray irradiation.

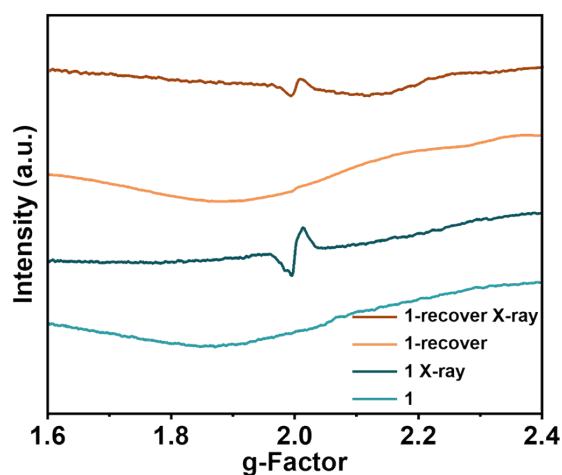


Figure S6. ESR spectra for **1** of before and after X-ray irradiation, and recovered upon heating treatment and then re-irradiation.

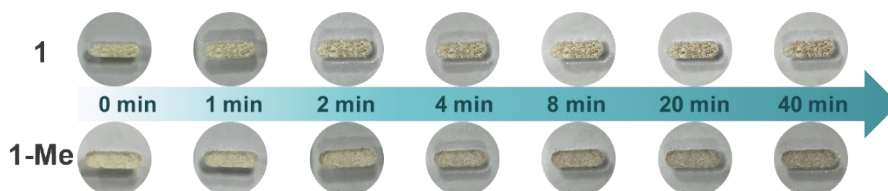


Figure S7. Time-dependent color change of crystal samples of **1** and **1-Me** (6 mm × 2 mm × 0.5 mm) under irradiation (W K α radiation source with a tube voltage of 225 KVp and a dose rate of 26.50 Gymin⁻¹).

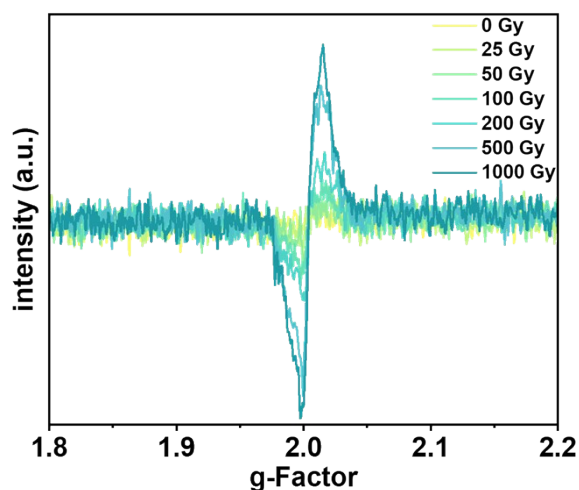


Figure S8. ESR spectra of **1** upon X-ray irradiation with different radiation dosages (W K α radiation source with a tube voltage of 225 KVp and a dose rate of 26.50 Gymin⁻¹).

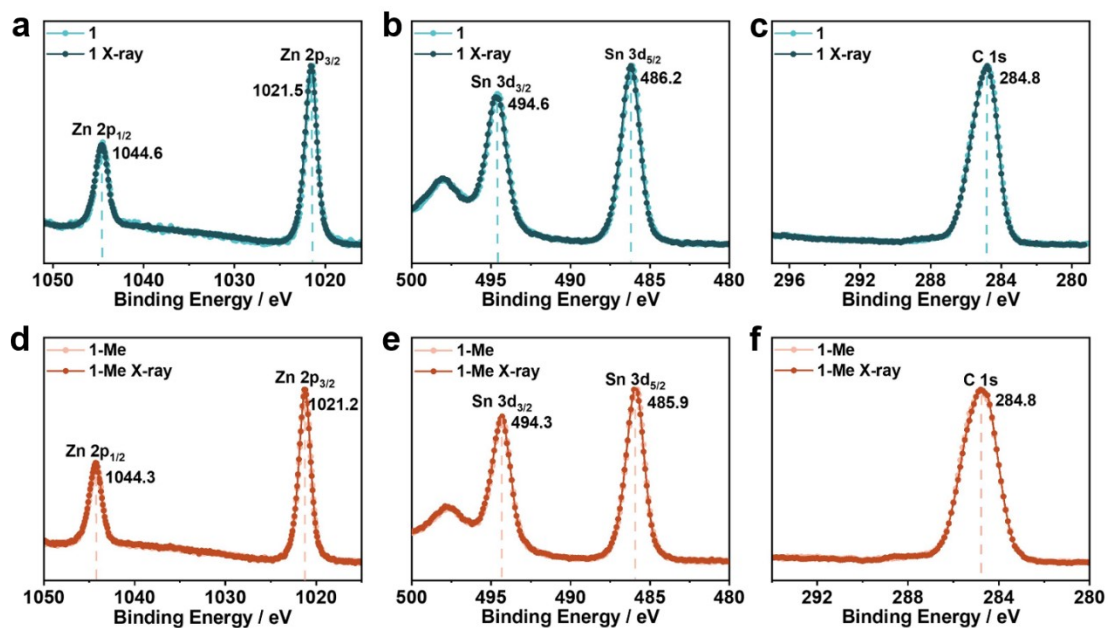


Figure S9. High resolution XPS spectra of **1** a) Zn 2p, b) Sn 3d and c) C 1s and **1-Me** d) Zn 2p, e) Sn 3d, and f) C 1s before and after X-ray irradiation.

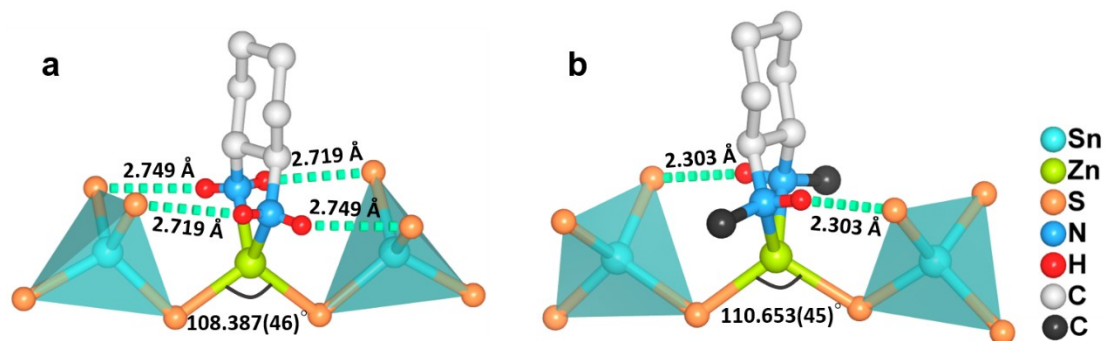


Figure S10. a) The [Zn(DAC)] bridged two T1-SnS₄ motif in **1** showing the N–H···S hydrogen bonds. b) The [Zn(DAC-Me)] bridged two T1-SnS₄ motif in **1-Me** showing the N–H···S hydrogen bonds.

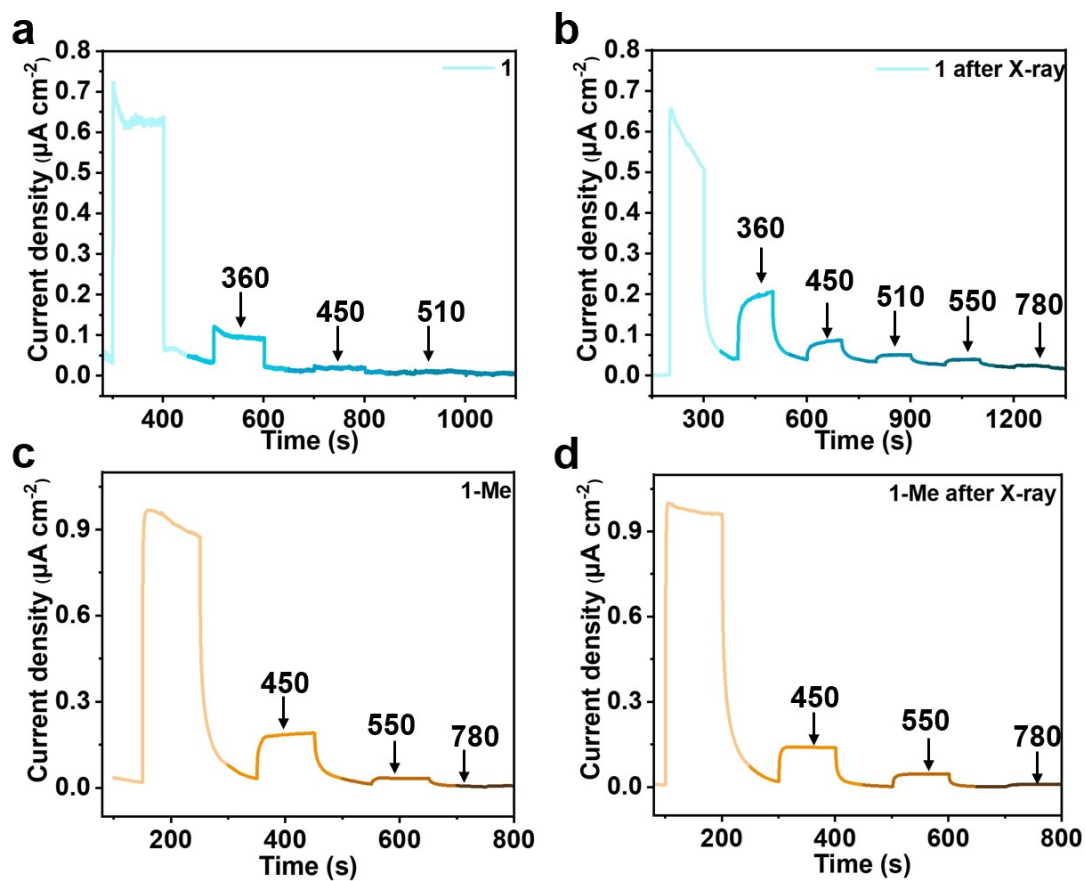


Figure S11. Photo response spectra of **1** a) before and b) after X-ray irradiation and **1-Me** c) before and d) after X-ray irradiation with different wavelength of the filters.

Table S1. Crystallographic data and structure refinement parameters for **1** and **1-Me**.

Compounds	1	1-Me
Framework Formula	$C_{12}H_{28}N_4S_4SnZn_2 \cdot H_2O$	$C_{16}H_{36}N_4S_4Zn_2Sn_1 \cdot H_2O$
Crystal system	Tetragonal	Tetragonal
Space group	<i>I</i> -42 <i>d</i>	<i>I</i> -42 <i>d</i>
<i>Z</i>	16	16
<i>a</i> (Å)	10.0687(4)	13.44118(7)
<i>b</i> (Å)	10.0687(4)	13.44118(7)
<i>c</i> (Å)	20.8088(7)	14.28207(11)
<i>α</i> (deg.)	90	90
<i>β</i> (deg.)	90	90
<i>γ</i> (deg.)	90	90
<i>V</i> (Å³)	2109.57(18)	2580.27(3)
GOF on <i>F</i>²	1.130	1.129
<i>R</i>₁, <i>wR</i>₂ (<i>I</i> > 2σ(<i>I</i>))	0.0254, 0.0549	0.0266, 0.0749
<i>R</i>₁, <i>wR</i>₂ (all data)	0.0300, 0.0588	0.0266, 0.0750